

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO.

298-147

SERIAL NO.

09/996,239



APPLICANT

Steinbichler et al.

FILING DATE

November 28, 2001

GROUP

Art Unit: 2856

## U.S. PATENT DOCUMENT

| EXAMINER<br>INITIALS |  |  | DOCUMENT NUMBER |   |   |   |   |   |   |  | DATE  | NAME          | CLASS | SUBCLASS | FILING DA<br>IF<br>APPROPRIA |
|----------------------|--|--|-----------------|---|---|---|---|---|---|--|-------|---------------|-------|----------|------------------------------|
|                      |  |  | 5               | 4 | 6 | 7 | 1 | 8 | 4 |  | 11/95 | Tenjimbayashi |       |          |                              |

## FOREIGN PATENT DOCUMENTS

|  |  |    |   |    |   |   |   |   |   |       |                             |  | CLASS | SUBCLASS |  |
|--|--|----|---|----|---|---|---|---|---|-------|-----------------------------|--|-------|----------|--|
|  |  |    | 0 | 4  | 1 | 9 | 9 | 3 | 6 | 04/91 | EUROPEAN                    |  |       |          |  |
|  |  | 1  | 9 | 6  | 3 | 9 | 2 | 1 | 3 | 03/98 | FEDERAL REPUBLIC OF GERMANY |  |       |          |  |
|  |  |    | 3 | 6  | 0 | 0 | 6 | 7 | 2 | 07/87 | FEDERAL REPUBLIC OF GERMANY |  |       |          |  |
|  |  | 1  | 9 | 8  | 5 | 9 | 7 | 2 | 5 | 07/00 | FEDERAL REPUBLIC OF GERMANY |  |       |          |  |
|  |  | 1  | 9 | 9  | 0 | 6 | 6 | 8 | 1 | 09/00 | FEDERAL REPUBLIC OF GERMANY |  |       |          |  |
|  |  |    | 4 | 2  | 3 | 1 | 5 | 7 | 8 | 03/94 | FEDERAL REPUBLIC OF GERMANY |  |       |          |  |
|  |  | WO | 0 | 0/ | 3 | 4 | 7 | 3 | 5 | 06/00 | INTERNATIONAL               |  |       |          |  |

Fomitchov et al. "a Compact dual-purpose Camera for shearography and electronic speckle-pattern Interferometry", Mens. Sci. Technol. 8 (1997), pp. 581-583

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.